# MSKSEMI 美森科













ESD

TVS

TSS

MOV

GDT

PIFD

## MSN74AHC1G32DxxR

Product specification





### **General Description**

This single 2-input positive- OR gate is designed for 1.65-V to 5.5-V Vcc operation.

The MSN74AHC1G32DxxR performs the Boolean function. Y=A+B or Y= $\overline{A}$ .  $\overline{B}$  in positive logic. The CMOS device has high output drive while maintaining low static power dissipation over a broad Vcc operating range.

The MSN74AHC1G32DxxR device is available in a variety of packages.

### **Features**

- Operatefrom1.65Vto5.5V
- Supports5-VVCCoperation
- Specifiedfrom-20°Cto85°C
- ProvidesdowntranslationtoV<sub>CC</sub>
- Maxtpdof3.8nsat3.3V
- ±24-mAoutputdriveat3.3V

### **Applications**

- Personalnavigationdevice(GPS)
- AVreceiver
- High-speeddataacquisitionandgeneration
- SSD:internalandexternal
- Digitalpictureframe(DPF)
- TV:LCD/digitalandhigh-definition(HDTV)

### **Reference News**

SOT-23-5	Pinning and Package	Marking
	VCC Y  5  4  1 2 3  A B GND	A <u>3</u> 2 <u>3</u>

SC70-5	Pinning and Package	Marking
	VCC Y  S  A  B  GND	<u>A</u> G <u>L</u>

### **Pin Functions**

Pi	Pin		Decemention	
Name	SOT23-5/SC70-5	Туре	Description	
А	1	I	Data Input	
В	2	I	Data Input	
GND	3	-	Ground	
Υ	4	0	Data Output	
Vcc	5	-	Supply Voltage	

### Order information

Orderable Device	Package	Packing Option
MSN74AHC1G32DBVR	SOT23-5	3000PCS
MSN74AHC1G32DCKR	SC70-5	3000PCS



### **Absolute Maximum Ratings**

	Parameters	Min	Max.	Unit	
Vcc	Supply voltage r	ange	-0.5	6.5	٧
Vı	Input voltage ra	ange	-0.5	6.5	٧
Vo	Voltage range applied to any output in the hi	gh-impedance or power-off state	-0.5	6.5	V
Vo	Voltage range applied to any outpu	ut in the high or low state	-0.5	Vcc+0.5	V
lıĸ	Input clamp current	Vi<0		-50	mA
<b>І</b> ок	Output clamp current	Vo<0		-50	mA
lo	Continuous output	current		±50	mA
	Continuous current through Vo		±100	mA	
TJ	Junction temperature under bias			85	$^{\circ}$
T <sub>stg</sub>	Storage temperature range			150	$^{\circ}$

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### **Functional Block Diagram**



### **ESD Ratings**

ESD			Value	Unit
V(ESD) Electrostatic Discharge		Human-Body Model (HBM) <sup>(1)</sup>	8 K	٧
		Charged-Device Model (CDM) <sup>(2)</sup>	1.5K	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### **Thermal Information**

Package Type	<b>Ө</b> ЈА	<b>Ө</b> лс	Unit
SOT23-5	250	81	°CM
SC70-5	400	150	°CW

<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



### **Recommended Operating Conditions**

Over operating free-air temperature range (unless otherwise noted)

Symbol	Pai	Min	Max	Units		
Vcc	Supply Voltage	Operating	1.65	5.5	V	
		V <sub>cc</sub> =1.65V to 1.95V	0.65×V <sub>CC</sub>			
Vih	High-Level Input Voltage	V <sub>CC</sub> =2.3V to 2.7V	1.7		V	
VIH	r ligit-Level illiput voltage	V <sub>CC</sub> =3V to 3.6V	2		_ v	
		V <sub>CC</sub> =4.5V to 5.5V	0.7×Vcc			
		V <sub>CC</sub> =1.65V to 1.95V		0.35×V <sub>CC</sub>		
VIL	Low-Level Input Voltage	V <sub>CC</sub> =2.3V to 2.7V		0.7	V	
VIL	Low-Level Input voltage	V <sub>CC</sub> =3V to 3.6V		0.8	_ v	
		V <sub>CC</sub> =4.5V to 5.5V		0.3×Vcc		
Vı	Inpu	ıt Voltage	0	5.5	V	
Vo	Outp	ut Voltage	0	Vcc	V	
		V <sub>CC</sub> =1.65V		-4		
		Vcc=2.3V		-8		
Юн	High-Level Output Current	V 0V		-16	mA	
		Vcc=3V		-24		
		Vcc=4.5V		-32		
		V <sub>CC</sub> =1.65V		4		
		Vcc=2.3V		8		
loL	Low-Level Output Current	V 9/		16	mA	
		Vcc=3V		24	1	
		Vcc=4.5V		32		
Δt/Δν		V <sub>CC</sub> =1.8V±0.15V, 2.5V±0.2V		20		
	Input Transition Rise or Fall Rate	V <sub>CC</sub> =3.3V±0.3V		10	ns/V	
		V <sub>CC</sub> =5V±0.5V		5	-	
TA	Operating Free-air Temperature	All Other Packages	-40	125	°C	

<sup>(1)</sup> All unused digital inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation.



### **Electrical Characteristics**

V<sub>CC</sub>=1.65V to 5.5V, FULL=-20°C to +85°C. Typical values are at TA=+25°C (unless otherwise noted)

Parameter	Symbol	<b>Test Conditions</b>	Vcc	TA	Min	Тур	Max	Units
		Output						
		l₀н=—100µА	1.65V to 5.5V	FULL	Vcc-0.			V
		loн=-4mA	1.65V	FULL	1.2			V
Output High Voltage	Vон	юн <b>=</b> —8mA	2.3V	FULL	1.9			V
		I <sub>OH</sub> =-16mA	0) (	FULL	2.4			V
		I <sub>OH</sub> =-24mA	3V	FULL	2.3			V
		I <sub>OH</sub> =-32mA	4.5V	FULL	3.8			V
		l <sub>OL</sub> =100μA	1.65V to 5.5V	FULL			0.1	V
	Vol	loL=4mA	1.65V	FULL			0.45	V
		loL=8mA	2.3V	FULL			0.3	V
Output Low Voltage		lo∟=16mA	21.6	FULL			0.4	V
		lo∟=24mA	3V	FULL			0.65	V
		l <sub>oL</sub> =32mA	4.5V	FULL			0.65	V
Off-State Current	off	V <sub>I</sub> or V <sub>O</sub> =5.5V	0V	FULL			±25	μA
1	<u> </u>	Input						
Input Leakage Current	h	V <sub>i</sub> =5.5V or GND	0V to 5.5V	FULL			±5	μA
Input Capacitance	Cı	Vi=Vcc or GND	3.3V	FULL		4		pF
		Power Supply						
Power Supply Range	Vcc		1.65V to 5.5V	FULL	1.65		5.5	V
Power Supply Current	lcc	V <sub>I</sub> =V <sub>CC</sub> or GND, I <sub>O</sub> =0		FULL			10	μA
Delta Power Current	ΔΙσο	One Input at V <sub>CC</sub> – 0.6V, Other Inputs at V <sub>CC</sub> or GND	3V to 5.5V	FULL			500	μA

<sup>1)</sup> All unused digital inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation.

Switching Characteristics Over recommended operating free-air temperature range,  $C_L$ =30pF or 50 pF (unless otherwise noted)

					-	20°C to +8	5°C				
Parameter	From(Input)	To(Output)	V <sub>cc</sub> =1.8\	/±0.15V	V <sub>cc</sub> =2.5	V±0.2V	V <sub>cc</sub> =3.3	V±0.3V	V <sub>cc</sub> =5V	±0.5V	Units
			Min	Max	Min	Max	Min	Max	Min	Max	
<b>t</b> pd	A or B	Y	1	9	1	3.8	1	3.8	1	3.3	ns

### **Operating Characteristics**

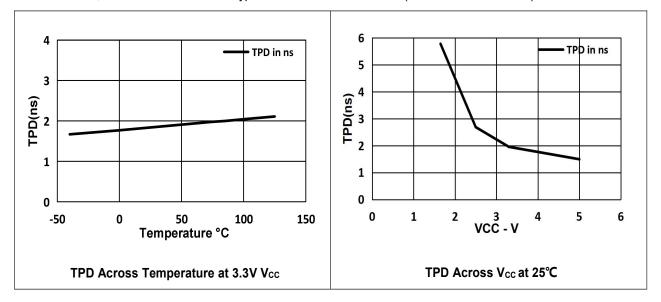
TA=- 20°C to +85°C

	Parameter	Test	Vcc=1.8V	Vcc=2.5V	Vcc=3.3V	Vcc=5V	Units
		Conditions	Тур	Тур	Тур	Тур	
C <sub>pd</sub>	Power Dissipation Capacitance	f=10Mhz	23	23	23	29	pF

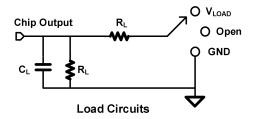


### **Typical Characteristics**

V<sub>CC</sub>=1.65V or 5.5V, FULL=-20°C to +85°C. Typical values are at TA=+25°C (unless otherwise noted)



### **Parameter Measurement Information**

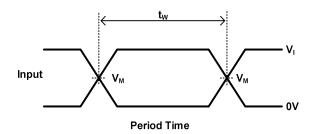


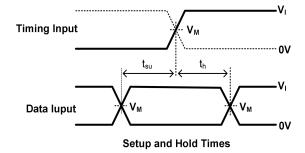
TEST	S1
TPHL/TPLH	OPEN
Tplz/Tpzl	VLOAD
T <sub>PHZ</sub> /T <sub>PZH</sub>	GND

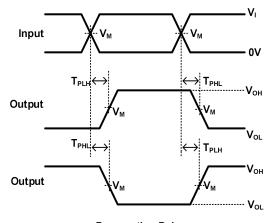
	INPUTS						
Vcc	Vı	T <sub>r</sub> /T <sub>f</sub>	Vм	VLOAD	CL	R∟	<b>V</b> A
1.8V±0.15V	Vcc	≤2ns	Vcc/2	2×Vcc	30pF	500Ω	0.15V
2.5V±0.15V	Vcc	≤2ns	Vcc/2	2×Vcc	30pF	500Ω	0.15V
3.3V±0.15V	3V	≤2.5ns	1.5V	6V	50pF	500Ω	0.3V
5V±0.15V	Vcc	≤2.5ns	Vcc/2	2×Vcc	50pF	500Ω	0.3V



### Parameter Measurement Information(Continued)







Propagation Delay for Output and Inverted Output

Enable and Disable Times Low-And High-Level Enabling

Notes:A.  $C_L$  includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR 10 MHz, Z = 50.

- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F.  $t_{\text{PZL}}$  and  $t_{\text{PZH}}$  are the same as  $t_{\text{en.}}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all device.

# Detailed Description Overview

The MSN74AHC1G32DxxR device contains one 2-input positive OR gate device and performs the Boolean function Y = A + B or  $Y = \overline{A \cdot B}$ . This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitrydisables the outputs, preventing damaging current backflow through the device when it is powered down. The  $I_{off}$  feature allows voltages on the inputs and outputs, when  $V_{CC}$  is 0 V.

### **Functional Block Diagram**





### **Feature Description**

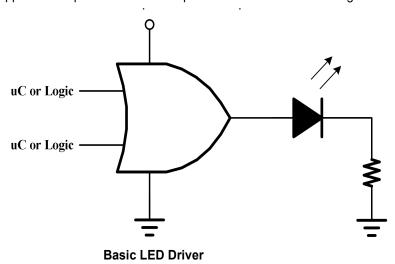
- Wide operating voltage range.
- Operates from 1.65 V to 5.5 V.
- Allows down voltage translation.
- Inputs accept voltages to 5.5 V.
- $l_{\text{off}}$  feature allows voltages on the inputs and outputs, when  $V_{\text{CC}}$  is 0 V.

### **Device Functional Modes**

Input	S	Output		
Α	В	Y		
Н	X	L		
X	Н	L		
L	L	Н		

### **Application Note**

The MSN74AHC1G32DxxR is a high drive CMOS device that can be used for implement OR logic with a high output drive ,such as an LED application. It can produce 24-mA of drive current at 3.3V making it Ideal for driving multiple outputs and good for high speed applications up to 100Mhz. The inputs are 5.5-V tolerant allowing translation down to Vcc

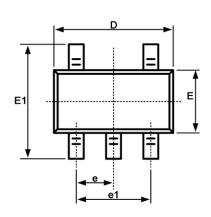


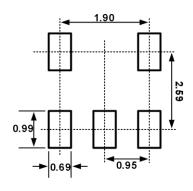
This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

Each VCC pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1-µF capacitor is recommended. If there are multiple VCC pins, then a 0.01-µF or 0.022-µF capacitor is recommended for each power pin. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1-µF and 1-µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

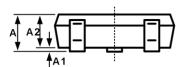


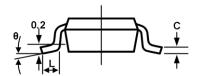
# Package Outline SOT23-5





Recommended Land Pattern (Unit: mm)

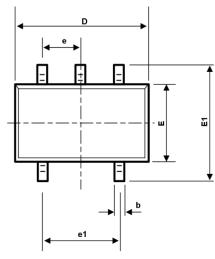


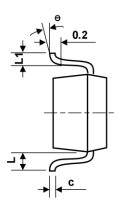


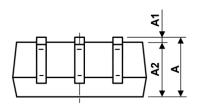
Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
	Min	Max	Min	Max	
A	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.950BSC		0.037BSC		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
L1	0.600REF		0.024REF		
θ	0°	8°	0°	8°	



# Package Outline SC70-5







symbol	Dimension I	n Millimeters	Dimensions In Inches	
	Min	Max	Min	Max
A	0.900	1.100	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.000	0.035	0.039
b	0.150	0.350	0.006	0.014
С	0.110	0.175	0.004	0.007
D	2.000	2.200	0.079	0.087
E	1.150	1.350	0.045	0.053
E1	2.150	2.450	0.085	0.096
е	0.650TYP		0.026TYP	
e1	1.200	1.400	0.047	0.055
L	0.525REF		0.021REF	
L1	0.260	0.460	0.010	0.018
θ	0°	8°	0°	8°



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